

GrayLIT Network Search Results for: seed AND "memory test"



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Documents from DTIC Report Collection(0 out of 0):

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Documents from the NASA Jet Propulsion Lab Reports (2 out of 2):

1.  ☐ Tantalum hot-electron bolometers for low-noise heterodyne receivers
We describe superconducting diffusion-cooled hot-electron bolometers that were fabricated from tantalum films grown on a thin niobium seed layer. The seed layer promotes single-phase growth of the Ta films, resulting in high-quality bolometers with transition temperatures up to 2.35 K and transition widths of less than 0.2 K. An S-parameter measurement set-up in a He-3 cryostat was used to measure device impedance versus frequency of a 400 nm long device at a temperature of
2.  ☐ High-T_c Edge-geometry SNS Weak Links on Silicon-on-sapphire Substrates
High-quality superconductor/normal-metal/superconductor(SNS) edge-geometry weak links have been produced on silicon-on-sapphire (SOS) substrates using a new SrTiO₃/'seed layer'/cubic-zirconia (YSZ) buffer system.

Documents from the NASA Langley Technical Reports (0 out of 0):